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# MOSFET – Power, Single, N-Channel 30 V, 140 A

# **NVTYS002N03CL**

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

## **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	29	Α
Current R <sub>θJA</sub>		T <sub>A</sub> = 100°C		20.5	
Power Dissipation $R_{\theta JA}$		T <sub>A</sub> = 25°C	P <sub>D</sub>	3.2	W
	Steady	T <sub>A</sub> = 100°C	1	1.6	1
Continuous Drain	State	T <sub>C</sub> = 25°C	I <sub>D</sub>	140	Α
Current R <sub>θJC</sub>		T <sub>C</sub> = 100°C		99	
Power Dissipation $R_{\theta JC}$		T <sub>C</sub> = 25°C	P <sub>D</sub>	75	W
		T <sub>C</sub> = 100°C		37	
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	675	Α
Operating Junction and S Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		
Source Current (Body Did	Is	62	Α		
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 10.6 A)			E <sub>AS</sub>	320	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

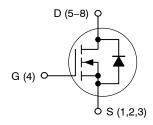


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V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX	
30 V	2.25 mΩ @ 10 V	140 A	
30 V	3.1 mΩ @ 4.5 V	140 A	

#### N-Channel MOSFET





# LFPAK8 3.3x3.3 CASE 760AD

# MARKING DIAGRAM

002N 03CL AWLYW

002N03CL = Specific Device Code

A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NVTYS002N03CLTWG	LFPAK33 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	47	C/VV

- 1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•	•	
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu A$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				17.1		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V	T <sub>J</sub> = 25°C			10	μΑ
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{DS} = 0 \text{ V}, V_{GS}$	<sub>S</sub> = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.3		2.2	٧
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-5.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		1.9	2.25	<b>~</b> 0
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 50 A		2.8	3.1	mΩ
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub>	<sub>0</sub> = 50 A		130		S
Gate Resistance	$R_{G}$				0.9		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 15 V			2697		
Output Capacitance	C <sub>OSS</sub>				1548		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				43		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 50 A			17		
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.8		nC
Gate-to-Source Charge	$Q_{GS}$				7		
Gate-to-Drain Charge	$Q_{GD}$				3.8		
Gate Plateau Voltage	$V_{GP}$				3		٧
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 V; I <sub>D</sub> = 50 A			37		nC
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 50 \text{ A}, R_{G} = 3.0 \Omega$			18		
Rise Time	t <sub>r</sub>				9		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				22		ns
Fall Time	t <sub>f</sub>				9		1

- 4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.
- 5. Switching characteristics are independent of operating junction temperatures.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 5)	•		•			
Turn-On Delay Time	t <sub>d(ON)</sub>			11.5		- ns	
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 15 V, $I_{D}$ = 50 A, $R_{G}$ = 3.0 $\Omega$			4		
Turn-Off Delay Time	t <sub>d(OFF)</sub>				32		
Fall Time	t <sub>f</sub>				5		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $I_{S} = 50 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.8	1.1	
					0.7		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			44		
Charge Time	t <sub>a</sub>				28		ns
Discharge Time	t <sub>b</sub>				13		
Reverse Recovery Charge	Q <sub>RR</sub>				28		nC

<sup>4.</sup> Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>5.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

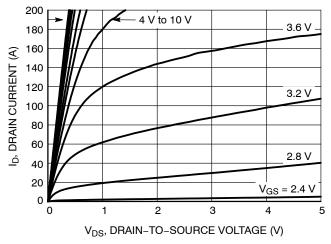


Figure 1. On-Region Characteristics

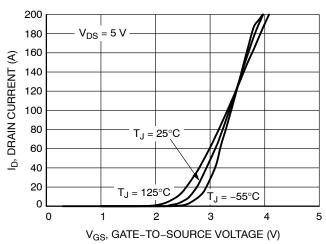


Figure 2. Transfer Characteristics

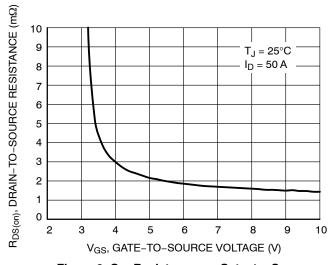


Figure 3. On-Resistance vs. Gate-to-Source Voltage

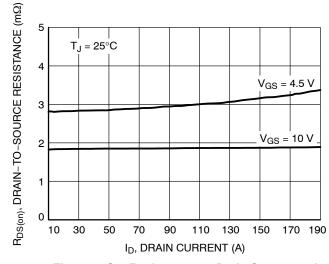


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

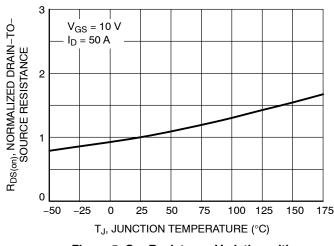


Figure 5. On–Resistance Variation with Temperature

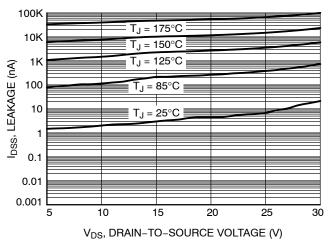
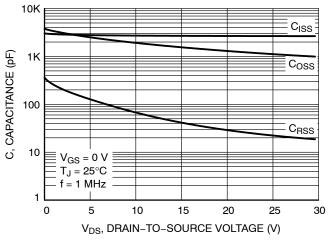


Figure 6. Drain-to-Source Leakage Current vs. Voltage

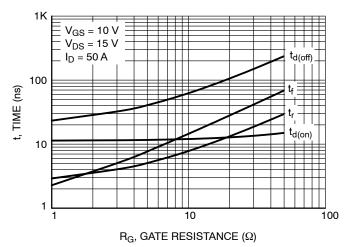
#### **TYPICAL CHARACTERISTICS**



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Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge



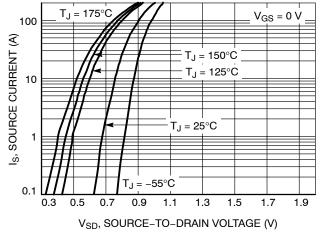
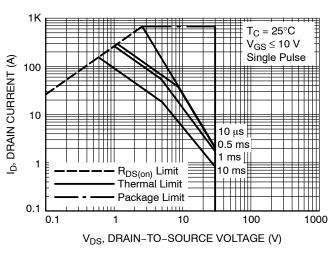


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current



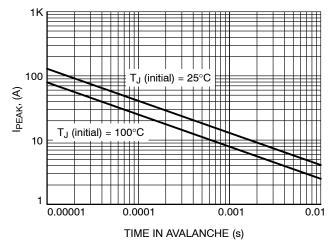


Figure 11. Maximum Rated Forward Biased Safe Operating Area

Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

# **TYPICAL CHARACTERISTICS**

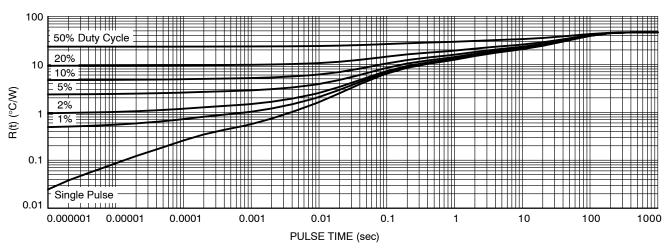
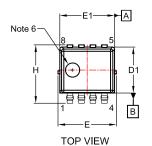


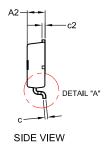
Figure 13. Thermal Characteristics

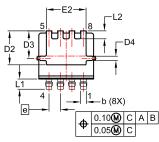
#### PACKAGE DIMENSIONS

# LFPAK8 3.3x3.3, 0.65P

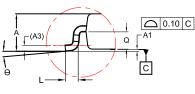
CASE 760AD ISSUE E



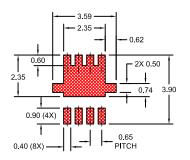








DETAIL 'A' SCALE: 2:1



# LAND PATTERN RECOMMENDATION

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14 5M 1994
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS OR BURRS SHALL NOT EXCEED 0,150mm PER SIDE,
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- 6. OPTIONAL MOLD FEATURE.

DIM	MILLIMETERS				
Diwi	MIN.	NOM.	MAX.		
Α	0.95	1.05	1.15		
A1	0.00	0.05	0.10		
A2	0.95	1.00	1.05		
A3		0.15 RE	F		
b	0.27	0.32	0.37		
С	0.12	0.17	0.22		
c2	0.12	0.17	0.22		
D1	2.50	2.60	2.70		
D2	1.82	1.92	2.02		
D3	1.46	1.56	1.66		
D4	0.20	0.25	0.30		
Е	3.20	3.30	3.40		
E1	3.00	3.10	3.20		
E2	2.15	2.25	2.35		
е	0.65 BSC				
I	3.20	3.30	3.40		
Г	0.25	0.37	0.50		
L1	0.48	0.58	0.68		
L2	0.35	0.45	0.55		
Q	0.45	0.50	0.55		
θ	0°	4°	8°		

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